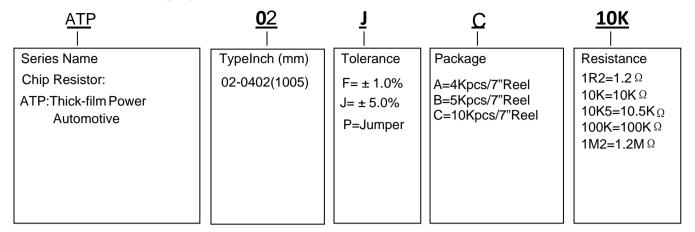
ALTERNATION HISTORY RECORDS 变更记录

Date 日期	Version 版本	Mark 标记	Page 页码	Description 描述	Drafter 制定者	Approver 审批者
2021-1-15	A	/	6	In release	Doris	/

1. Part Numbering System):



FEATURE

- 1. High reliability and stability ±1%
- 2. Sulfuration resistant ASTM B-809 60'C 500 hrs
- 3. Automotive AEC Q-200 & Military MIL-STD Compliant
- 4. 100% CCD inspection
- 5. RoHS 2 compliant and Halogen free products

APPLICATION

- Automotive application
- · Consumer electrical equipment
- EDP, Computer application
- Telecom application

DESCRIPTION

The resistors are constructed in a high grade ceramic body (aluminum oxide). Internal metal electrodes are added at each end and connected by a resistive paste that is applied to the top surface of the substrate. The composition of the paste is adjusted to give the approximate resistance required and the value is trimmed to within tolerance by laser cutting of this resistive layer.

The resistive layer is covered with a protective coat. Finally, the two external end terminations are added. For ease of soldering the outer layer of these end terminations is a Tin (lead free) alloy.

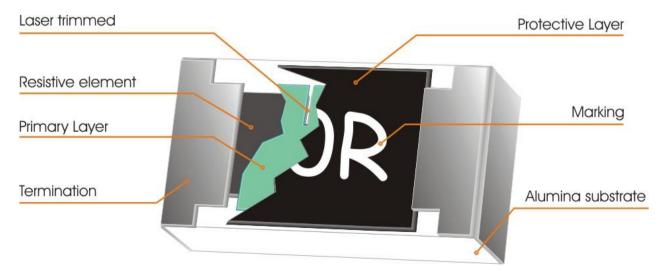


Fig 1. Construction of a Chip-R

QUICK REFERENCE DATA

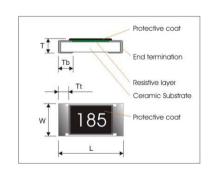
Item	General Specification		
Series No.	ATP02		
Size code	0402(1005)		
Resistance	1Ω~10MΩ (±5% tolerance), Jumper		
Range	1Ω~10MΩ (±1% tolerance)		
Resistance Tolerance	±1% ±5% E96/E24 E24		
TCR (ppm/°C)			
R > 1MΩ	$\leq \pm 200$		
10Ω < R \leq 1M Ω	≤ ± 100		
$R \le 10\Omega$	-200~+400		
Max. dissipation @ T _{amb} =70°C	1/10 W		
Max. Operation Voltage (DC or RMS)	50V		
Max. Overload Voltage (DC or RMS)	100V		
Climatic category	55/155/56		
(IEC 60068)			

Note:

- 1. This is the maximum voltage that may be continuously supplied to the resistor element, see "IEC publication 60115-8"
- Max. Operation Voltage: So called RCWV (Rated Continuous Working Voltage) is determined by
 RCWV = √RatedPower × Resistance Value or Max. RCWV listed above, whichever is lower.
- 3. The resistance of Jumper is defined $< 0.05\Omega$.

DIMENSIONS (unit: mm)

Size	ATP02	
L	1.00 ± 0.05	
W	0.50 ± 0.05	
Т	0.35 ± 0.05	
Tb	0.25 ± 0.10	
Tt	0.20 ± 0.10	



MARKING

Size \ Nr. Of digit of code\tolerance	±5%	±1%
0402(1005)	NO MAR	KING

Derating

The power that the resistor can dissipate depends on the operating temperature; see Fig.2.1

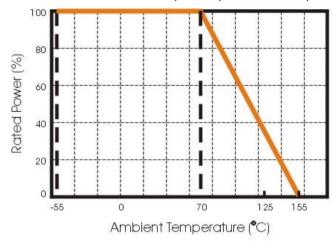


Figure 2.1 Maximum dissipation in percentage of rated power as a function of the ambient temperature

MOUNTING

Due to their rectangular shapes and small tolerances, Surface Mountable Resistors are suitable for handling by automatic placement systems.

Chip placement can be on ceramic substrates and printed-circuit boards (PCBs).

Electrical connection to the circuit is by individual soldering condition.

The end terminations guarantee a reliable contact.

SOLDERING CONDITION

The robust construction of chip resistors allows them to be completely immersed in a solder bath 260°C for 10 seconds. Therefore, it is possible to mount Surface Mount Resistors on one side of a PCB and other discrete components on the reverse (mixed PCBs).

Surface Mount Resistors are tested for solderability at 235°C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds. Typical examples of soldering processes that provide reliable joints without any damage are given in Fig 3.

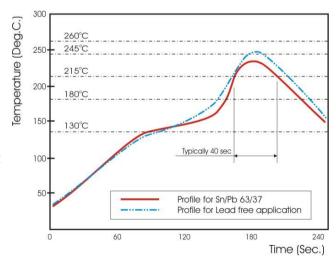


Fig 3. Infrared soldering profile for Chip Resistors

TEST AND REQUIREMENTS

Essentially all tests are carried out according to the schedule of IEC publication 115-8, category LCT/UCT/56(rated temperature range: Lower Category Temperature, Upper Category Temperature; damp heat, long term, 56 days). The testing also meets the requirements specified by EIA, EIAJ and JIS.

The tests are carried out in accordance with IEC publication 68, "Recommended basic climatic and mechanical robustness testing procedure for electronic components" and under standard atmospheric conditions according to IEC 60068-1, sub-clause 5.3. Unless otherwise specified, the following value supplied:

Temperature: 15°C to 35°C. Relative humidity: 45% to 75%.

Air pressure: 86kPa to 106 kPa (860 mbar to 1060 mbar). All soldering tests are performed with midly activated flux.

TEST	PROCEDURE / TEST METUOR	REQUIREMENTS		
TEST	PROCEDURE / TEST METHOD	Resistance	0Ω	
Electrical Characteristics	- DC resistance values measurement	Within the specified tolerance		
	- Temperature Coefficient of Resistance (T.C.R)	Refer to "QUICK REFERENC	E DATA"	
JISC5201-1: 1998	Natural resistance change per change in degree centigrade.			
Clause 4.8	$\frac{R_2 - R_1}{R_1(t_2 - t_1)} \times 10^6 \text{ (ppm/°C)} t_1 : 20^{\circ}\text{C} + 5^{\circ}\text{C} - 1^{\circ}\text{C}$			
	R ₁ : Resistance at reference temperature			
	R ₂ : Resistance at test temperature			
Resistance to soldering	Un-mounted chips completely immersed for 10±1second in a	Δ R/R max. ±(0.5%+0.05Ω)		
heat (R.S.H)	SAC solder bath at 270°C±5°C	No visible damage	<50mΩ	
MIL-STD-202 method 210			V0011122	
Solderability	a) Bake the sample for 155°C dwell time 4hrs/ solder dipping 235°C / 5sec.	95% coverage min., good tir	nning and	
J-STD-002	b) Steam the sample dwell time 1 hour/ solder dipping 260°C/7sec.	no visible damage		
Temperature cycling JESD22 method JA-104	1000 cycles, -55°C ~ +155°C, dwell time 5~10min	Δ R/R max. \pm (0.5%+0.05 Ω) No visible damage	<50mΩ	
	65±2°C, 80~100% RH, 10 cycles, 24 hours/ cycle			
Moisture Resistance	100±2 0, 00~100 /6 1011, 10 cycles, 24 flours/ cycle	Δ R/R max. \pm (0.5%+0.05 Ω)	<50mΩ	
MIL-STD-202 method 106		No visible damage		
	1000+48/-0 hours; 85°C, 85% RH, 10% of operation power			
Bias Humidity MIL-STD-202	1000+40/-0 flours, 65 G, 65 /6 ft ft, 10 /6 of operation power	Δ R/R max. \pm (1%+0.05 Ω)	<50mΩ	
method 103		No visible damage		
Operational Life	1000+48/-0 hours; 35% of operation power, 125±2°C			
MIL-STD-202 method		Δ R/R max. \pm (1%+0.05 Ω)	<50mΩ	
108		No visible damage		

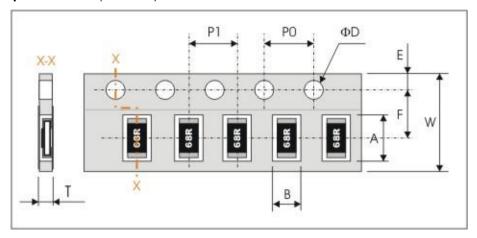
TEST	PROCEDURE / TEST METUOR	REQUIREMENTS		
TEST	PROCEDURE / TEST METHOD	Resistance ±5%, ±1%	0Ω	
High Temperature	1000+48/-0 hours; without load in a temperature chamber	Δ R/R max. \pm (1%+0.05 Ω)		
Exposure	controlled 155±3°C	No visible damage	<50mΩ	
MIL-STD-202			<2011175	
method 108				
Mechanical Shock	1/2 Sine Pulse / 1500g Peak / Velocity 15.4ft/sec	Within the specified	ļ	
MIL-STD-202		tolerance	$<$ 50m Ω	
method 213		No visible damage		
Board Flex	Resistors mounted on a 90mm glass epoxy resin PCB(FR4),	Δ R/R max. \pm (1.0%+0.05 Ω).	<50mΩ	
AEC-Q200-005	bending once 2mm for 10sec	No visible damage	<5011102	
Terminal strength	Pressurizing force: 1Kg, Test time: 60±1sec.	No remarkable damage or removal of		
AEC-Q200-006		the		
		terminations		
Vibration	Test 5g's for 20min., 12 cycles each of 3 orientations	Δ R/R max. \pm (1.0%+0.05 Ω)		
MIL-STD-202		No visible damage	$<$ 50m Ω	
method 204				
Thermal shock	Test –55 to 155°C/ dwell time 15min/ Max transfer time 20sec	Δ R/R max. ±(0.5%+0.05Ω)		
MIL-STD-202	300cycles	No visible damage	<50mΩ	
method 107				
ESD	Test contact 1.0KV (0.5KV for 0402 only)	Δ R/R max. \pm (1%+0.05 Ω)	.F0C	
AEC-Q200-002		No visible damage	<50mΩ	

TEST CONDITION FOR JUMPER (0 Ω)

Item	ATP02	
Power Rating At 70°C	1/10W	
Resistance	MAX.50m $Ω$	
Rated Current	1A	
Peak Current	3A	
Operating Temperature	-55 ~ +155°C	

PACKAGING

Paper Tape specifications (unit :mm)



Series No.	А	В	W	F	E
ATP02	1.20±0.10	0.70±0.10	8.00±0.30	3.50±0.20	1.75±0.10

Series No.	P1	P0	ΦD	Т
ATP02	2.00±0.10	4.00±0.10	Φ 1.50 $^{+0.1}_{-0.0}$	0.40±0.05

7"

